## Effect of tetravalent dopants on hematite nanostructure for enhanced photoelectrochemical water splitting

Improvement of the electrical conductivity of semiconductor metal oxides is one of the most profound challenges in the development of high performance photoanodes for photoelectrochemical (PEC) water splitting. Hematite  $(\alpha - Fe_2O_3)$  is considered an ideal metal-oxide semiconductor photoanode for PEC applications, owing to its stability, suitable band gap (2.2 eV), low cost and non-toxic nature. However, pristine  $\alpha - Fe_2O_3$  exhibits poor performance due to short hole diffusion lengths (2–4 nm) and low electron mobility. Doping of  $\alpha - Fe_2O_3$  photoanodes has been extensively investigated to improve its photoelectrochemical properties. In this work, the influence of tetravalent dopants such as Si<sup>4+</sup>, Sn<sup>4+</sup>, Ti<sup>4+</sup>, and Zr<sup>4+</sup> on the hematite ( $\alpha - Fe_2O_3$ ) nanostructure for enhanced photoelectrochemical (PEC) water splitting are reported. The tetravalent doping was performed on hydrothermally grown akaganeite ( $\beta$ -FeOOH) nanorods on FTO (fluorine-doped tin-oxide) substrates via a simple dipping method for which the respective metal-precursor solution was used, followed by a high-temperature (800° C) sintering in a box furnace.